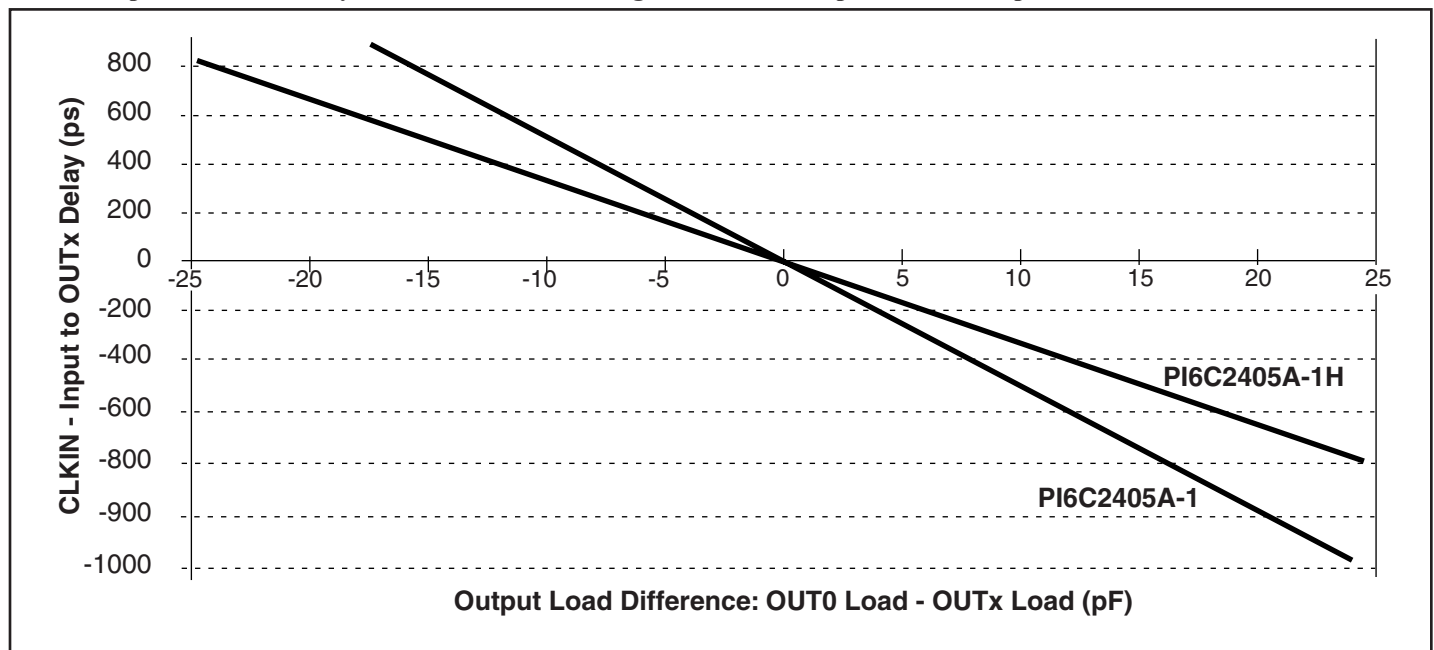


Zero Delay and Skew Control

CLKIN Input to OUTx Delay vs. Difference in Loading between OUT0 pin and OUTx pins



The relationship between loading of the OUT0 signal and other outputs determines the input-output delay. Zero delay is achieved when all outputs, including feedback, are loaded equally.

Maximum Ratings

Supply Voltage to Ground Potential.....	-0.5V to +7.0V
DC Input Voltage (Except CLKIN).....	-0.5V to $V_{DD} + 0.5V$
DC Input Voltage CLKIN	-0.5 to 7V
Storage Temperature	-65°C to +150°C
Maximum Soldering Temperature (10 seconds)	260°C
Junction Temperature	150°C
Static Discharge Voltage (per MIL-STD-883, Method 3015).....	>2000V

Operating Conditions ($V_{CC} = 3.3V \pm 0.3V$)

Parameter	Description	Min.	Max.	Units
V_{DD}	Supply Voltage	3.0	3.6	V
T_A	Commerical Operating Temperature	0	70	°C
	Industrial Operating Temperature	-40	85	
C_L	Load Capacitance, below 100 MHz		30	pF
	Load Capacitance, from 100 MHz to 133		15	
C_{IN}	Input Capacitance		7	

DC Electrical Characteristics for Industrial Temperature Devices

Parameter	Description	Test Conditions	Min.	Max.	Units
V _{IL}	Input LOW Voltage			0.8	V
V _{IH}	Input HIGH Voltage		2.0		
I _{IL}	Input LOW Current	V _{IN} = 0V		50	μA
I _{IH}	Input HIGH Current	V _{IN} = V _{DD}		125	
V _{OL}	Output LOW Voltage	I _{OL} = -8mA(-1); I _{OL} = 12mA(-1H)		0.4	V
V _{OH}	Output HIGH Voltage	I _{OH} = -8mA(-1); I _{OH} = -12mA(-1H)	2.4		
I _{DD}	Supply Current	Unloaded outputs 100 MHz, Select inputs at V _{DD} or GND		54	mA
		Unloaded outputs 66 MHz, CLKIN		39	

AC Electrical Characteristics for Industrial Temperature Devices

Parameter	Description	Test Conditions	Min.	Typ.	Max.	Units
F _O	Output Frequency	30pF load	10		100	MHz
		15pF load	10		133	
t _{DC}	Duty Cycle ⁽¹⁾ (-1)	Measured at V _{DD} /2, F _{OUT} < 66.67MHz, 30pF load	40	50	60	%
		Measured at V _{DD} /2, F _{OUT} < 45MHz 15pF load	45		55	
	Duty Cycle ⁽¹⁾ (-1H)	Measured at V _{DD} /2, F _{OUT} < 100MHz 15pF load	40		60	
		Measured at V _{DD} /2, F _{OUT} < 45MHz 30pF load	45		55	
t _R	Rise Time ⁽¹⁾ (-1)	Measured between 0.8V and 2.0V, 30pF load			2.2	ns
		Measured between 0.8V and 2.0V, 15pF load			1.5	
	Rise Time ⁽¹⁾ (-1H)	Measured between 0.8V and 2.0V, 30pF load			1.7	
t _F	Fall Time ⁽¹⁾ (-1)	Measured between 0.8V and 2.0V, 30pF load			2.2	
		Measured between 0.8V and 2.0V, 15pF load			1.5	
	Fall Time ⁽¹⁾ (-1H)	Measured between 0.8V and 2.0V, 30pF load			1.5	
t _{sk(o)}	Output to Output skew (-1, -1H) ⁽¹⁾	All outputs equally loaded			200	ps
t ₀	Delay, CLKIN Rising Edge to OUT0 Rising Edge ⁽¹⁾	Measured at V _{DD} /2		0	±300	
t _{SK(D)}	Device-to-device skew ⁽¹⁾	Measured at V _{DD} /2 on OUT0 pins of device		0	600	
t _{SLEW}	Output slew rate ⁽¹⁾	Measured between 0.8V and 2.0V on -1H device using Test Circuit #2	1			V/ns
t _{JIT}	Cycle-to-Cycle Jitter (-1, -1H)	Measured at 66.67 MHz, loaded 30pF load			200	ps
t _{LOCK}	PLL Lock time ⁽¹⁾	Stable power supply, valid clocks presented on CLKIN pin			1.0	ms

Notes:

1. See Switching Waveforms on page 5.

DC Electrical Characteristics for Commercial Temperature Devices

Parameter	Description	Test Conditions	Min.	Max.	Units
V _{IL}	Input LOW Voltage			0.8	V
V _{IH}	Input HIGH Voltage		2.0		
I _{IL}	Input LOW Current	V _{IN} = 0V		50	μA
I _{IH}	Input HIGH Current	V _{IN} = V _{DD}		125	
V _{OL}	Output LOW Voltage	I _{OL} = -8mA(-1); I _{OL} = 12mA(-1H)		0.4	V
V _{OH}	Output HIGH Voltage	I _{OH} = -8mA(-1); I _{OH} = -12mA(-1H)	2.4		
I _{DD}	Supply Current	Unloaded outputs 100 MHz, Select inputs at V _{DD} or GND		54	mA
		Unloaded outputs 66.67 MHz, select inputs at V _{DD} or GND		39	

AC Electrical Characteristics for Commercial Temperature Devices

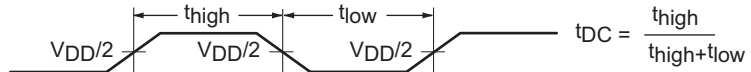
Parameter	Description	Test Conditions	Min.	Typ.	Max.	Units
F _O	Output Frequency	30pF load	10		100	MHz
		15pF load	10		133	
t _{DC}	Duty Cycle ⁽¹⁾ (-1)	Measured at V _{DD} /2, F _O < 66 MHz, 30pF load	40	50	60	%
	Duty Cycle ⁽¹⁾ (-1H)	Measured at V _{DD} /2, F _O < 66 MHz, 30pF load	45	50	55	
t _R	Rise Time ⁽¹⁾ @ 30pF	Measured between 0.8V and 2.0V			2.2	ns
	Rise Time ⁽¹⁾ @ 15pF				1.5	
	Rise Time ⁽¹⁾ @ 30pF (-1H)				1.5	
t _F	Fall Time ⁽¹⁾ @ 30pF	Measured between 0.8V and 2.0V			2.2	
	Fall Time ⁽¹⁾ @ 15pF				1.5	
	Fall Time ⁽¹⁾ @ 30pF (-1H)				1.5	
t _{sk(o)}	Output to Output skew (-1, -1H) ⁽¹⁾	All outputs equally loaded			200	ps
t ₀	Input to output delay, CLKIN Rising Edge to OUT0 Rising Edge ⁽¹⁾	Measured at V _{DD} /2		0	±300	
t _{SK(D)}	Device-to-device skew ⁽¹⁾	Measured at V _{DD} /2 on OUT0 pins of device		0	600	
t _{SLEW}	Output slew rate ⁽¹⁾	Measured between 0.8V and 2.0V on -1H device using Test Circuit #2	1			V/ns
t _{JIT}	Cycle-to-Cycle Jitter (-1, -1H)	Measured at 66.67 MHz, loaded 30pF load			200	ps
t _{LOCK}	PLL Lock time ⁽¹⁾	Stable power supply, valid clocks presented on CLKIN pin			1.0	ms

Notes:

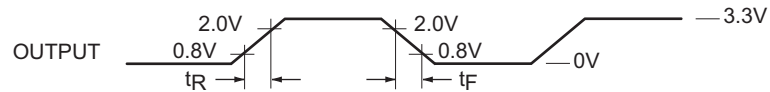
1. See Switching Waveforms on page 5.

Switching Waveforms

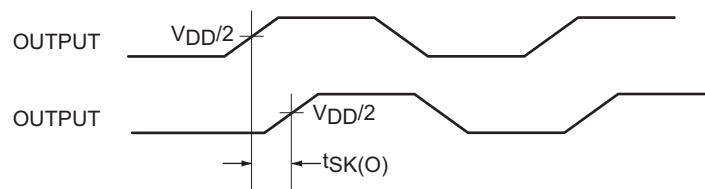
Duty Cycle Timing



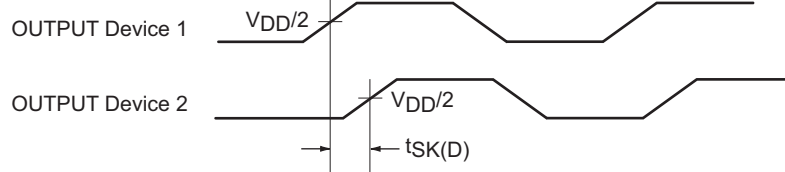
All Outputs Rise/Fall Time



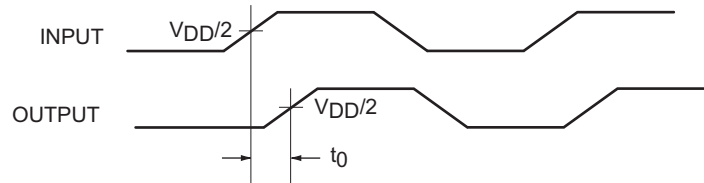
Output-Output Skew



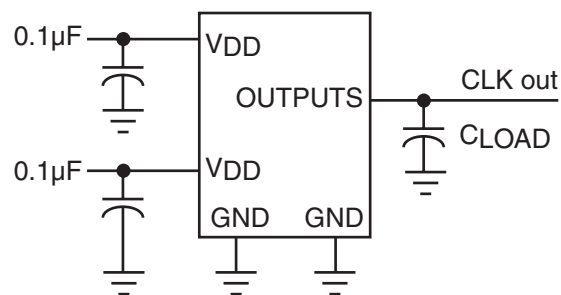
Device-Device Skew



Input-Output Propagation Delay

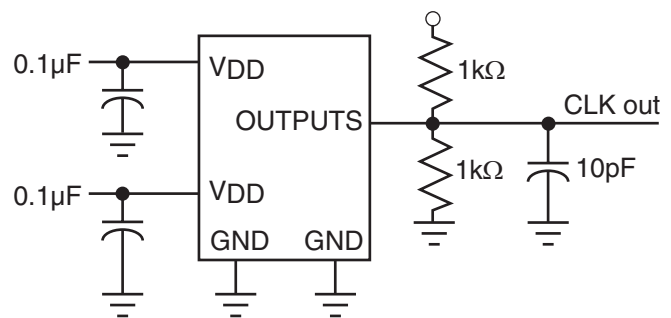


Test Circuit 1

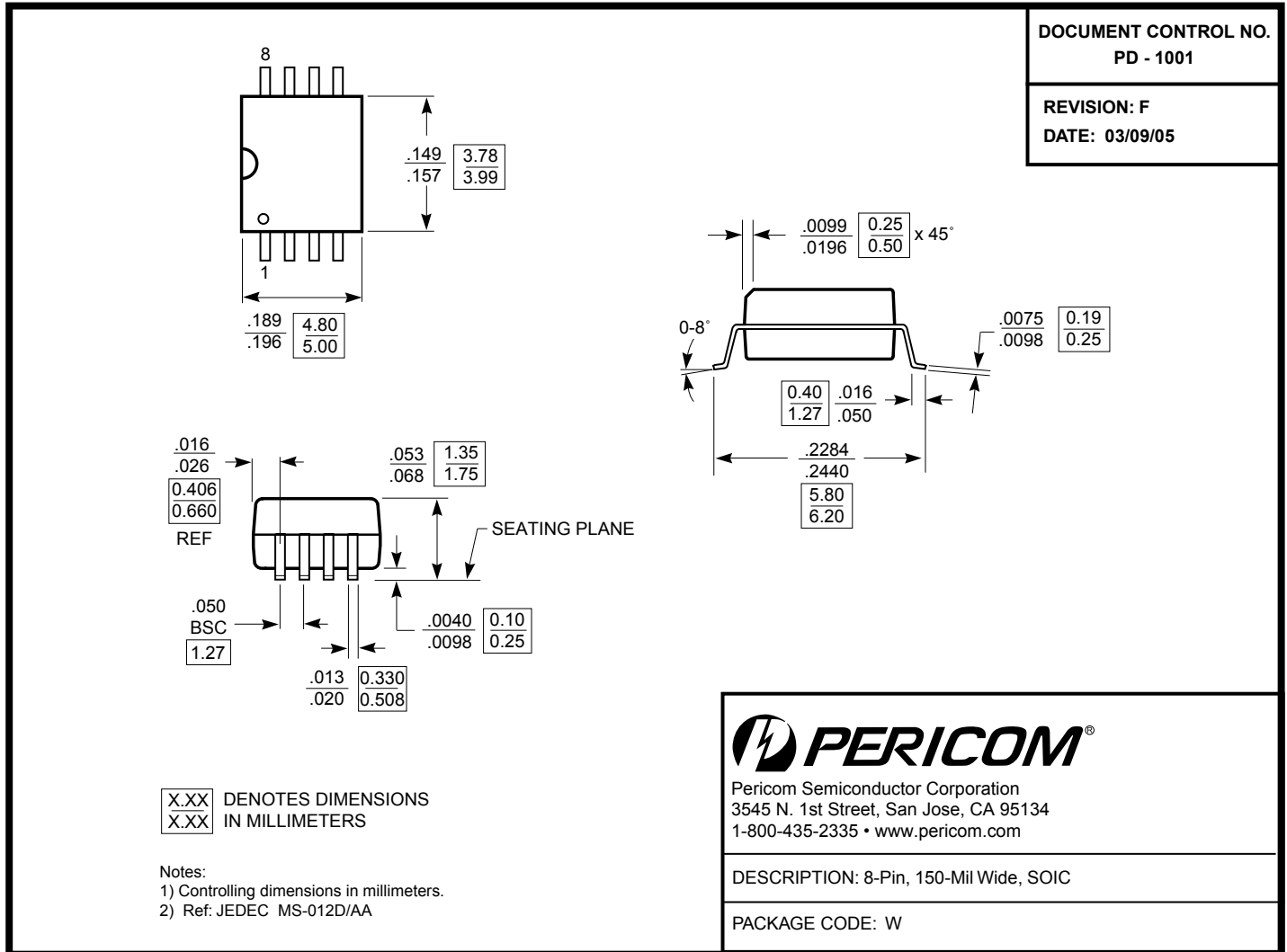


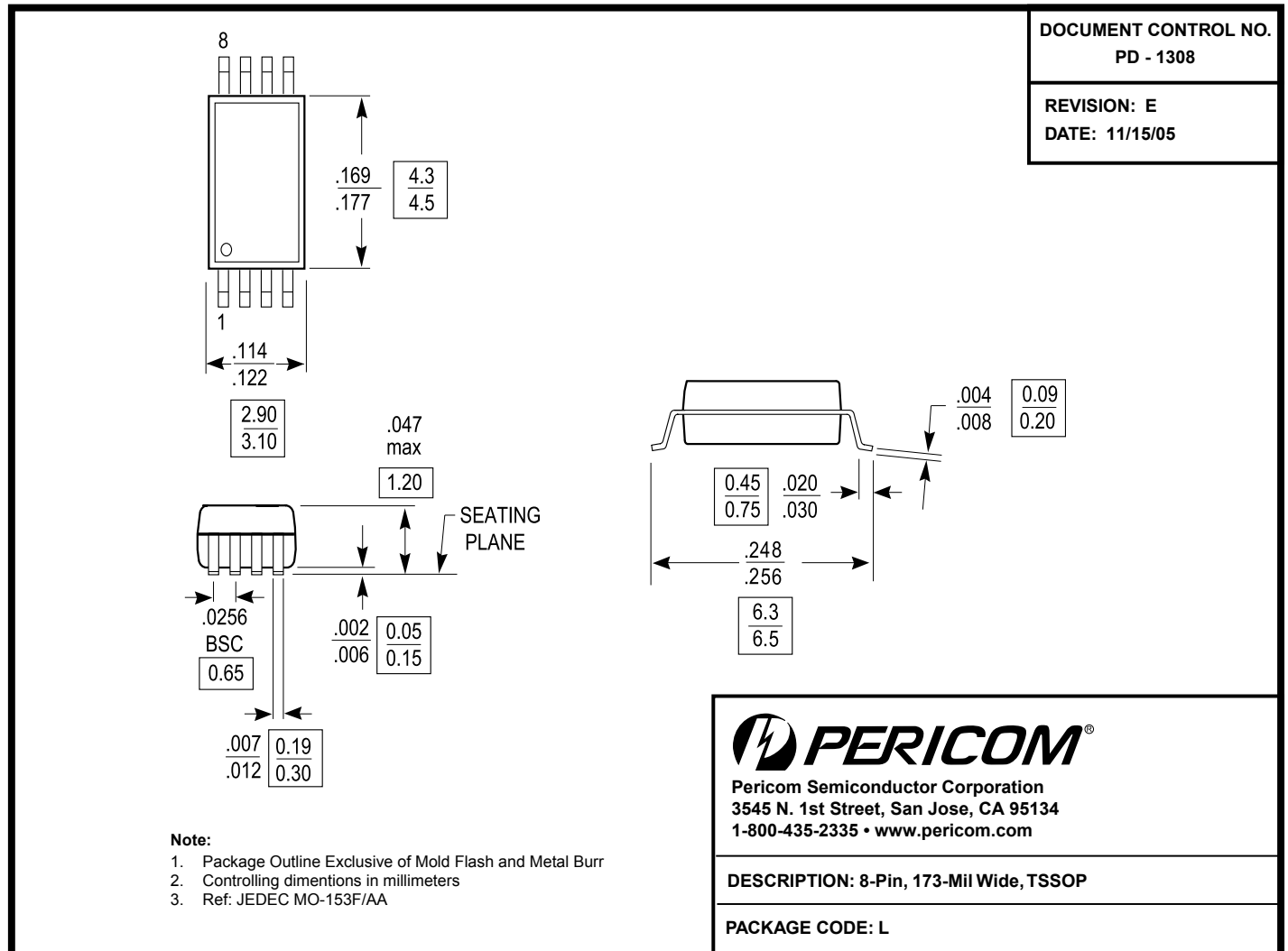
Test Circuit for all parameters except t_{SLEW}

Test Circuit 2



Test Circuit for t_{SLEW} , Output slew rate on -1H device

Packaging Mechanical: 8-Pin SOIC (W)


Packaging Mechanical: 8-Pin TSSOP (L)


Ordering Information for Commercial Operating Ranges

Ordering Code	Package Code	Package Description
PI6C2405A-1HWE	W	Pb-free & Green, 8-pin 150-mil SOIC
PI6C2405A-1LE	L	Pb-free & Green, 8-pin 173-mil TSSOP
PI6C2405A-1HLE	L	Pb-free & Green, 8-pin 173-mil TSSOP

Ordering Information for Industrial Operating Ranges

Ordering Code	Package Code	Package Description
PI6C2405A-1HWIE	W	Pb-free & Green, 8-pin 150-mil SOIC
PI6C2405A-1LIE	L	Pb-free & Green, 8-pin 173-mil TSSOP
PI6C2405A-1HLIE	L	Pb-free & Green, 8-pin 173-mil TSSOP

Notes:

1. Thermal characteristics can be found on the company web site at www.pericom.com/packaging/
2. X = Tape/Reel
3. E = Pb-free & Green